

MOSFET - N & P-Channel, POWERTRENCH®

FDC6333C

General Description

These N & P-Channel MOSFETs are produced using **onsemi**'s advanced POWERTRENCH process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

These devices have been designed to offer exceptional power dissipation in a very small footprint for applications where the bigger more expensive SO-8 and TSSOP-8 packages are impractical.

Features

- Q1 2.5 A, 30 V
 - $R_{DS(on)} = 95 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$
 - $R_{DS(on)} = 150 \text{ m}\Omega$ @ $V_{GS} = 4.5 \text{ V}$
- *Q2* -2.0 A, -30 V
 - $R_{DS(on)} = 130 \text{ m}\Omega$ @ $V_{GS} = -10 \text{ V}$
 - $R_{DS(on)} = 220 \text{ m}\Omega @ V_{GS} = -4.5 \text{ V}$
- Low Gate Charge
- High Performance Trench Technology for Extremely Low R_{DS(on)}
- SUPERSOT[™] -6 Package: Small Footprint (72% Smaller than SO-8); Low Profile (1 mm Thick)
- This is a Pb-Free Device

Applications

- DC-DC Converter
- Load Switch
- LCD Display Inverter

	V _{DSS}	R _{DS(ON)} MAX	I _D MAX
Q1	30 V	95 mΩ @ 10 V	2.5 A
		150 mΩ @ 4.5 V	
Q2	-30 V	130 mΩ @ –10 V	-2.0 A
		220 mΩ @ -4.5 V	



MARKING DIAGRAM

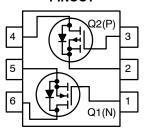


333 = Specific Device Code M = Assembly Operation Month

■ = Pb-Free Package

(Note: Microdot may be in either location)

PINOUT



ORDERING INFORMATION

See detailed ordering and shipping information on page 8 of this data sheet.

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted.)

		Rati			
Symbol	Parameter	Q1	Q2	Unit	
V _{DSS}	Drain-Source Voltage		30	-30	V
V _{GSS}	Gate-Source Voltage	Gate-Source Voltage			V
I _D	Drain Current – Continuous (Note 1a)	2.5	-2.0	Α	
	Drain Current – Pulsed	8	-8	1	
P_{D}	Power Dissipation for Single Operation (Note 1a)		0.96		W
	(Note 1b)		0	.9	1
	(Note 1c)		0	0.7	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		–55 to	+150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{ hetaJA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	130	°C/W
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	60	°C/W

R_{θJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{θJC} is guaranteed by design while R_{θCA} is determined by the user's board design.



a. 130°C/W when mounted on a 0.125 in² pad of 2 oz. copper.



b. 140°C/W when mounted on a 0.004 in² pad of 2 oz. copper.



c. 180°C/W when mounted on a minimum pad.

FLECTRICAL CHARACTERISTICS (T. - 25°C unless otherwise noted.)

Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit
OFF CHARA	CTERISTICS						
BV _{DSS}	Drain-Source Breakdown	Q1	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30	-	_	V
	Voltage	Q2	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-30	-	_	
ΔBV_{DSS}	Breakdown Voltage	Q1	I _D = 250 μA, Ref. to 25°C	-	27	_	mV/°C
ΔT_{J}		Q2	I _D = -250 μA, Ref. to 25°C	-	-22	-	
I _{DSS}	I _{DSS} Zero Gate Voltage Drain Current	Q1	V _{DS} = 24 V, V _{GS} = 0 V	-	-	1	μΑ
		Q2	$V_{DS} = -24 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	-1	
I _{GSSF}	Gate-Body Leakage, Forward	Q1	V _{GS} = 16 V, V _{DS} = 0 V	-	-	100	nA
		Q2	V _{GS} = 25 V, V _{DS} = 0 V	-	-	100	
I _{GSSR}	Gate-Body Leakage, Reverse	Q1	$V_{GS} = -16 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	-100	nA
			$V_{GS} = -25 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	-100	
ON CHARAC	CTERISTICS (Note 2)						
V _{GS(th)}	Gate Threshold Voltage	Q1	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1	1.8	3	V
		Q2	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-1	-1.8	-3	
$\Delta V_{GS(th)}$	Gate Threshold Voltage	Q1	I _D = 250 μA, Ref. to 25°C	-	4	-	mV/°C
ΔT_{\perp}	Temperature Coefficient		I _D = -250 μA, Ref. to 25°C	_	-4	_	

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted.) (continued)

Symbol	Parameter		Test Conditions	Min	Тур	Max	Unit
N CHARAC	CTERISTICS (Note 2)	•			•		
R _{DS(on)}	Static Drain-Source	Q1	V _{GS} = 10 V, I _D = 2.5 A	-	73	95	mΩ
	On-Resistance		V _{GS} = 4.5 V, I _D = 2.0 A	-	90	150	
			V _{GS} = 10 V, I _D = 2.5 A, T _J = 125°C	-	106	148	
		Q2	$V_{GS} = -10 \text{ V}, I_D = -2.0 \text{ A}$	-	95	130	
			V _{GS} = -4.5 V, I _D = -1.7 A	-	142	220	
			V _{GS} = 10 V, I _D = -2.0 A, T _J = 125°C	-	149	216	
I _{D(on)}	On-State Drain Current	Q1	V _{GS} = 10 V, V _{DS} = 5 V	8	-	_	Α
		Q2	V _{GS} = -10 V, V _{DS} = -5 V	-8	-	_	
9FS	Forward Transconductance	Q1	V _{DS} = 5 V, I _D = 2.5 A	-	7	-	S
			$V_{DS} = -5 \text{ V}, I_D = -2.0 \text{ A}$	-	3	_	
YNAMIC C	HARACTERISTICS						
C _{iss}	Input Capacitance	Q1	V _{DS} = 15 V, V _{GS} = 0 V, f = 1.0 MHz	-	282	_	pF
		Q2	V _{DS} = -15 V, V _{GS} = 0 V, f = 1.0 MHz	-	185	_	
C _{oss}	C _{oss} Output Capacitance	Q1	V _{DS} = 15 V, V _{GS} = 0 V, f = 1.0 MHz	-	49	_	
		Q2	V _{DS} = -15 V, V _{GS} = 0 V, f = 1.0 MHz	-	56	_	
C _{rss} Re	Reverse Transfer Capacitance	Q1	V _{DS} = 15 V, V _{GS} = 0 V, f = 1.0 MHz	-	20	-	
			$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	-	26	-	
WITCHING	CHARACTERISTICS (Note 2)						
t _{d(on)} Turn-On Delay Time	Q1	For <i>Q1</i> :	-	4.5	9	ns	
		Q2	V_{DS} = 15 V, I_{DS} = 1 A, V_{GS} = 10 V, R_{GEN} = 6 Ω	-	4.5	9	
t _r	Turn-On Rise Time	Q1	For $Q2$: $V_{DS} = -15 \text{ V}, I_{DS} = -1 \text{ A},$ $V_{GS} = -10 \text{ V}, R_{GEN} = 6 \Omega$	-	6	12	
		Q2		-	13	23	
t _{d(off)}	Turn-Off Delay Time	Q1		-	19	34	
	,			-	11	20	
t _f	Turn-Off Fall Time	Q1		-	1.5	3	
		Q2		-	2	4	
Qg	Total Gate Charge	Q1	For Q1:	-	4.7	6.6	nC
		Q2	V_{DS} = 15 V, I_{DS} = 2.5 A, V_{GS} = 10 V, R_{GEN} = 6 Ω	-	4.1	5.7	
Q _{gs}	Gate-Source Charge	Q1	For <i>Q2</i> :	-	0.9	-	
		Q2	$V_{DS} = -15 \text{ V}, I_{DS} = -2.0 \text{ A}, V_{GS} = -10 \text{ V}$	-	0.8	-	1
Q _{gd}	Gate-Drain Charge	Q1		-	0.6	-	
		Q2		-	0.4	_	
RAIN-SOU	RCE DIODE CHARACTERISTICS	AND	MAXIMUM RATINGS				
I _S	Maximum Continuous	Q1		-	-	0.8	Α
is	Drain-Source Diode Forward		1			0.0	
is	Current	Q2		-	_	-0.8	
V _{SD}		Q2 Q1	V _{GS} = 0 V, I _S = 0.8 A (Note 2)	_	0.8	-0.8 1.2	V

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. Pulse Test: Pulse Width < 300 µs, Duty Cycle < 2.0%

TYPICAL CHARACTERISTICS: N-CHANNEL

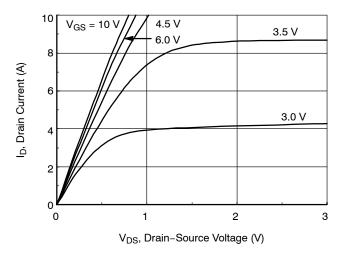


Figure 1. On-Region Characteristics

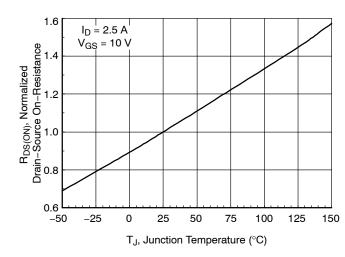


Figure 3. On-Resistance Variation with Temperature

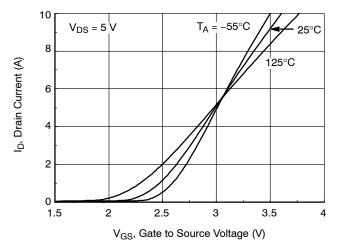


Figure 5. Transfer Characteristics

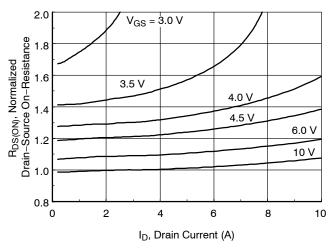


Figure 2. On–Resistance Variation with Drain Current and Gate Voltage

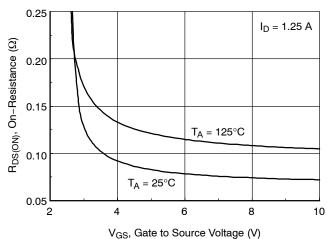


Figure 4. On–Resistance Variation with Gate–to–Source Voltage

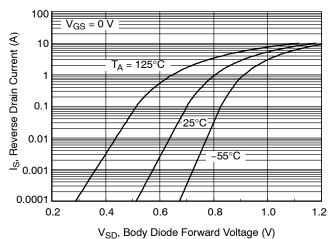
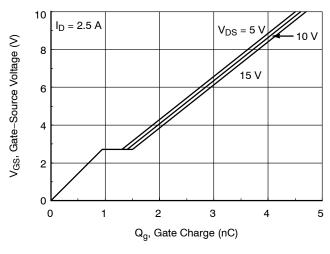


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

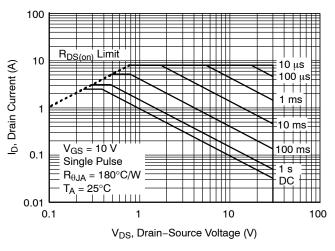
TYPICAL CHARACTERISTICS: N-CHANNEL (continued)



400 f = 1 MHz $V_{GS} = 0 V$ 300 Capacitance (pF) C_{ISS} 200 100 $\mathsf{C}_{\operatorname{OSS}}$ C_{RSS} 0 5 10 15 20 0 25 30 V_{DS}, Drain to Source Voltage (V)

Figure 7. Gate Charge Characteristics

Figure 8. Capacitance Characteristics



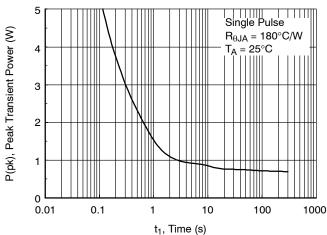
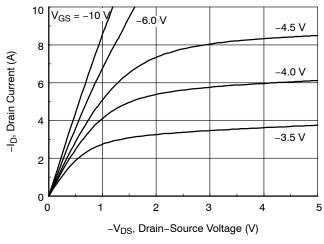


Figure 9. Maximum Safe Operating Area

Figure 10. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS: P-CHANNEL

 $V_{GS} = -3.5 \text{ V}$



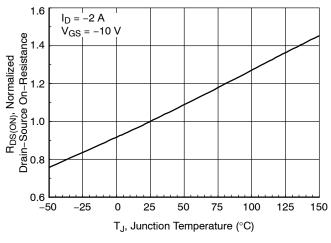
Dain Current (A)

Oxford

Oxfo

Figure 11. On-Region Characteristics

Figure 12. On–Resistance Variation with Drain Current and Gate Voltage



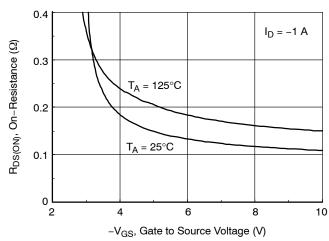
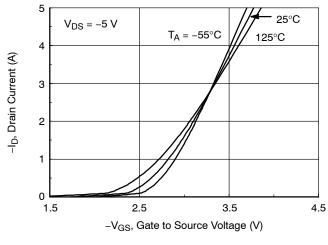


Figure 13. On–Resistance Variation with Temperature

Figure 14. On-Resistance Variation with Gate-to-Source Voltage



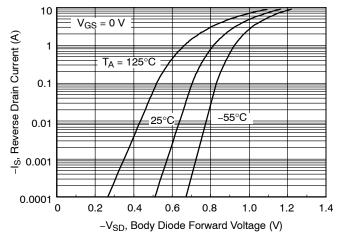


Figure 15. Transfer Characteristics

Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature

TYPICAL CHARACTERISTICS: P-CHANNEL (continued)

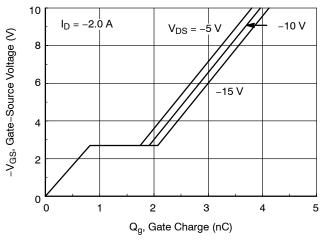


Figure 17. Gate Charge Characteristics

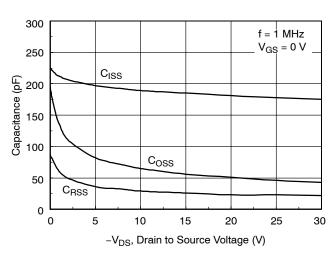


Figure 18. Capacitance Characteristics

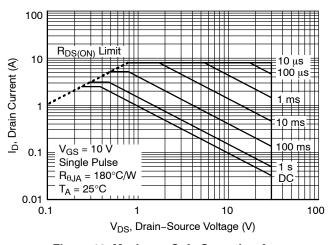


Figure 19. Maximum Safe Operating Area

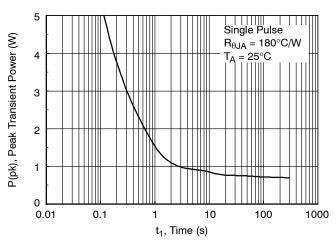


Figure 20. Single Pulse Maximum Power Dissipation

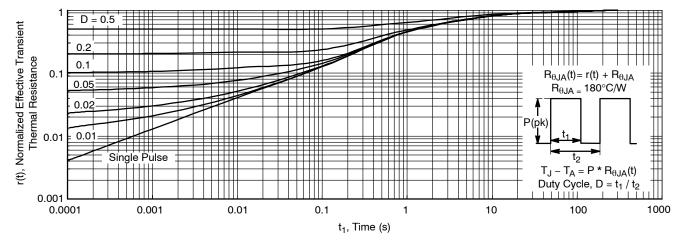


Figure 21. Transient Thermal Response Curve

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

ORDERING INFORMATION

Device	Device Marking	Package Type	Reel Size	Tape Width	Shipping [†]
FDC6333C	333	TSOT-23-6 (Pb-Free)	7"	8 mm	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

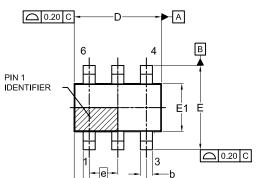
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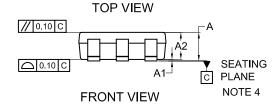
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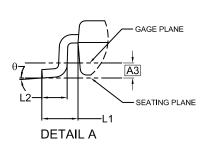
TSOT23 6-Lead CASE 419BL **ISSUE A**

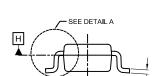
DATE 31 AUG 2020





e1





NOTES:

SIDE VIEW

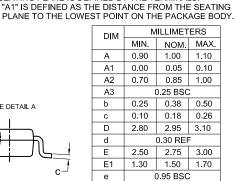
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0.95
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1.

LAND PATTERN RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.



1.90 BSC

0.60 REF

0.40

0.60 10°

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009. CONTROLLING DIMENSION: MILLIMETERS
 DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH,
 PROTRUSIONS, OR GATE BURRS. MOLD FLASH,

PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.25MM PER END. DIMENSIONS D AND E1 ARE

e1

L1

L2

θ

0.20

0°

4. SEATING PLANE IS DEFINED BY THE TERMINALS.

DETERMINED AT DATUM H.

GENERIC MARKING DIAGRAM*



XXX = Specific Device Code

= Date Code M

= Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	TSOT23 6-Lead		PAGE 1 OF 1		

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